



## 1.8V Low-Power Wide-Range Frequency Clock Driver

### Recommended Application:

- DDR2 Memory Modules / Zero Delay Board Fan Out
- Provides complete DDR DIMM logic solution with ICSSTU32864/SSTUF32864/SSTUF32866/SSTUA32864/SSTUA32866/SSTUA32S868/SSTUA32S865/SSTUA32S869

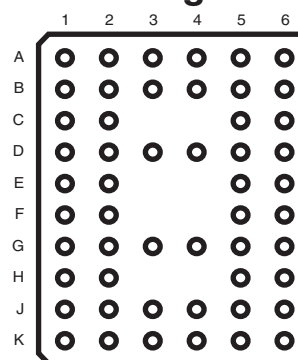
### Product Description/Features:

- Low skew, low jitter PLL clock driver
- 1 to 10 differential clock distribution (SSTL\_18)
- Feedback pins for input to output synchronization
- Spread Spectrum tolerant inputs
- Auto PD when input signal is at a certain logic state

### Switching Characteristics:

- Period jitter: 40ps (DDR2-400/533)  
30ps (DDR2-667/800)
- Half-period jitter: 60ps (DDR2-400/533)  
50ps (DDR2-667/800)
- OUTPUT - OUTPUT skew: 40ps (DDR2-400/533)  
30ps (DDR2-667/800)
- CYCLE - CYCLE jitter 40ps

### Pin Configuration

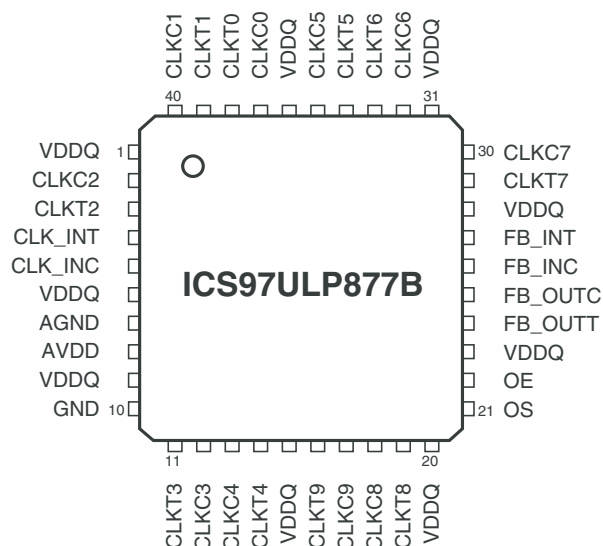
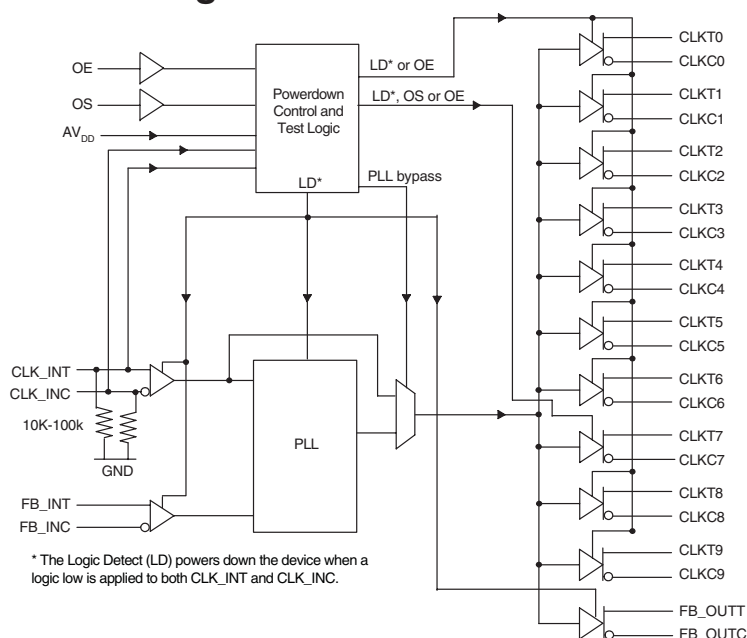


52-Ball BGA

Top View

|   | 1       | 2     | 3     | 4     | 5     | 6       |
|---|---------|-------|-------|-------|-------|---------|
| A | CLKT1   | CLKT0 | CLKC0 | CLKC5 | CLKT5 | CLKT6   |
| B | CLKC1   | GND   | GND   | GND   | GND   | CLKC6   |
| C | CLKC2   | GND   | NB    | NB    | GND   | CLKC7   |
| D | CLKT2   | VDDQ  | VDDQ  | VDDQ  | OS    | CLKT7   |
| E | CLK_INT | VDDQ  | NB    | NB    | VDDQ  | FB_INT  |
| F | CLK_INC | VDDQ  | NB    | NB    | OE    | FB_INC  |
| G | AGND    | VDDQ  | VDDQ  | VDDQ  | VDDQ  | FB_OUTC |
| H | AVDD    | GND   | NB    | NB    | GND   | FB_OUTT |
| J | CLKT3   | GND   | GND   | GND   | GND   | CLKT8   |
| K | CLKC3   | CLKC4 | CLKT4 | CLKT9 | CLKC9 | CLKC8   |

### Block Diagram



40-Pin MLF



## Pin Descriptions

| Terminal Name    | Description                                                       | Electrical Characteristics |
|------------------|-------------------------------------------------------------------|----------------------------|
| AGND             | Analog Ground                                                     | Ground                     |
| AV <sub>DD</sub> | Analog power                                                      | 1.8 V nominal              |
| CLK_INT          | Clock input with a (10K-100K Ohm) pulldown resistor               | Differential input         |
| CLK_INC          | Complementary clock input with a (10K-100K Ohm) pulldown resistor | Differential input         |
| FB_INT           | Feedback clock input                                              | Differential input         |
| FB_INC           | Complementary feedback clock input                                | Differential input         |
| FB_OUTT          | Feedback clock output                                             | Differential output        |
| FB_OUTC          | Complementary feedback clock output                               | Differential output        |
| OE               | Output Enable (Asynchronous)                                      | LVC MOS input              |
| OS               | Output Select (tied to GND or V <sub>DDQ</sub> )                  | LVC MOS input              |
| GND              | Ground                                                            | Ground                     |
| V <sub>DDQ</sub> | Logic and output power                                            | 1.8V nominal               |
| CLKT[0:9]        | Clock outputs                                                     | Differential outputs       |
| CLKC[0:9]        | Complementary clock outputs                                       | Differential outputs       |
| NB               | No ball                                                           |                            |

The PLL clock buffer, **ICS97ULP877B**, is designed for a V<sub>DDQ</sub> of 1.8 V, a AV<sub>DD</sub> of 1.8 V and differential data input and output levels. Package options include a plastic 52-ball VFBGA and a 40-pin MLF.

**ICS97ULP877B** is a zero delay buffer that distributes a differential clock input pair (CLK\_INT, CLK\_INC) to ten differential pair of clock outputs (CLKT[0:9], CLKC[0:9]) and one differential pair feedback clock outputs (FB\_OUTT, FB\_OUTC). The clock outputs are controlled by the input clocks (CLK\_INT, CLK\_INC), the feedback clocks (FB\_INT, FB\_INC), the LVC MOS program pins (OE, OS) and the Analog Power input (AV<sub>DD</sub>). When OE is low, the outputs (except FB\_OUTT/FB\_OUTC) are disabled while the internal PLL continues to maintain its locked-in frequency. OS (Output Select) is a program pin that must be tied to GND or V<sub>DDQ</sub>. When OS is high, OE will function as described above. When OS is low, OE has no effect on CLK7/CLKC7 (they are free running in addition to FB\_OUTT/FB\_OUTC). When AV<sub>DD</sub> is grounded, the PLL is turned off and bypassed for test purposes.

When both clock signals (CLK\_INT, CLK\_INC) are logic low, the device will enter a low power mode. An input logic detection circuit on the differential inputs, independent from the input buffers, will detect the logic low level and perform a low power state where all outputs, the feedback and the PLL are OFF. When the inputs transition from both being logic low to being differential signals, the PLL will be turned back on, the inputs and outputs will be enabled and the PLL will obtain phase lock between the feedback clock pair (FB\_INT, FB\_INC) and the input clock pair (CLK\_INT, CLK\_INC) within the specified stabilization time t<sub>STAB</sub>.

The PLL in **ICS97ULP877B** clock driver uses the input clocks (CLK\_INT, CLK\_INC) and the feedback clocks (FB\_INT, FB\_INC) to provide high-performance, low-skew, low-jitter output differential clocks (CLKT[0:9], CLKC[0:9]). **ICS97ULP877B** is also able to track Spread Spectrum Clocking (SSC) for reduced EMI.

**ICS97ULP877B** is characterized for operation from 0°C to 70°C.



## Function Table

| Inputs    |    |    |         |         | Outputs                   |                           |         |         | PLL          |
|-----------|----|----|---------|---------|---------------------------|---------------------------|---------|---------|--------------|
| AVDD      | OE | OS | CLK_INT | CLK_INT | CLKT                      | CLKC                      | FB_OUTT | FB_OUTC |              |
| GND       | H  | X  | L       | H       | L                         | H                         | L       | H       | Bypassed/Off |
| GND       | H  | X  | H       | L       | H                         | L                         | H       | L       | Bypassed/Off |
| GND       | L  | H  | L       | H       | *L(Z)                     | *L(Z)                     | L       | H       | Bypassed/Off |
| GND       | L  | L  | H       | L       | *L(Z),<br>CLKT7<br>active | *L(Z),<br>CLKC7<br>active | H       | L       | Bypassed/Off |
| 1.8V(nom) | L  | H  | L       | H       | *L(Z)                     | *L(Z)                     | L       | H       | On           |
| 1.8V(nom) | L  | L  | H       | L       | *L(Z),<br>CLKT7<br>active | *L(Z),<br>CLKC7<br>active | H       | L       | On           |
| 1.8V(nom) | H  | X  | L       | H       | L                         | H                         | L       | H       | On           |
| 1.8V(nom) | H  | X  | H       | L       | H                         | L                         | H       | L       | On           |
| 1.8V(nom) | X  | X  | L       | L       | *L(Z)                     | *L(Z)                     | *L(Z)   | *L(Z)   | Off          |
| 1.8V(nom) | X  | X  | H       | H       | Reserved                  |                           |         |         |              |

\*L(Z) means the outputs are disabled to a low stated meeting the I<sub>ODL</sub> limit.



## Absolute Maximum Ratings

|                               |                                |
|-------------------------------|--------------------------------|
| Supply Voltage (VDDQ & AVDD)  | -0.5V to 2.5V                  |
| Logic Inputs                  | GND - 0.5V to $V_{DDQ} + 0.5V$ |
| Ambient Operating Temperature | 0°C to +70°C                   |
| Storage Temperature           | -65°C to +150°C                |

Stresses above those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only and functional operation of the device at these or any other conditions above those listed in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

## Electrical Characteristics - Input/Supply/Common Output Parameters

TA = 0 - 70°C; Supply Voltage AVDDQ, VDDQ = 1.8 V +/- 0.1V (unless otherwise stated)

| PARAMETER                                     | SYMBOL      | CONDITIONS                        | MIN             | TYP  | MAX  | UNITS |
|-----------------------------------------------|-------------|-----------------------------------|-----------------|------|------|-------|
| Input High Current<br>(CLK_INT, CLK_INC)      | $I_{IH}$    | $V_I = V_{DDQ}$ or GND            |                 |      | ±250 | μA    |
| Input Low Current (OE,<br>OS, FB_INT, FB_INC) | $I_{IL}$    | $V_I = V_{DDQ}$ or GND            |                 |      | ±10  | μA    |
| Output Disabled Low<br>Current                | $I_{ODL}$   | OE = L, $V_{ODL} = 100mV$         | 100             |      |      | μA    |
| Operating Supply<br>Current                   | $I_{DD1.8}$ | $C_L = 0pf$ @ 270MHz              |                 |      | 200  | mA    |
|                                               | $I_{DDL D}$ | $C_L = 0pf$                       |                 |      | 500  | μA    |
| Input Clamp Voltage                           | $V_{IK}$    | $V_{DDQ} = 1.7V$ $I_{in} = -18mA$ |                 |      | -1.2 | V     |
| High-level output<br>voltage                  | $V_{OH}$    | $I_{OH} = -100 \mu A$             | $V_{DDQ} - 0.2$ |      |      | V     |
|                                               |             | $I_{OH} = -9 mA$                  | 1.1             | 1.45 |      | V     |
| Low-level output<br>voltage                   | $V_{OL}$    | $I_{OL} = 100 \mu A$              |                 | 0.25 | 0.10 | V     |
|                                               |             | $I_{OL} = 9 mA$                   |                 |      | 0.6  | V     |
| Input Capacitance <sup>1</sup>                | $C_{IN}$    | $V_I = GND$ or $V_{DDQ}$          | 2               |      | 3    | pF    |
| Output Capacitance <sup>1</sup>               | $C_{OUT}$   | $V_{OUT} = GND$ or $V_{DDQ}$      | 2               |      | 3    | pF    |

<sup>1</sup>Guaranteed by design, not 100% tested in production.

**Recommended Operating Condition** (see note1) $T_A = 0 - 70^{\circ}\text{C}$ ; Supply Voltage AVDD, VDDQ = 1.8 V +/- 0.1V (unless otherwise stated)

| PARAMETER                                  | SYMBOL             | CONDITIONS                            | MIN                   | TYP        | MAX                   | UNITS              |
|--------------------------------------------|--------------------|---------------------------------------|-----------------------|------------|-----------------------|--------------------|
| Supply Voltage                             | $V_{DDQ}, A_{VDD}$ |                                       | 1.7                   | 1.8        | 1.9                   | V                  |
| Low level input voltage                    | $V_{IL}$           | CLK_INT, CLK_INC, FB_INC, FB_INT      |                       |            | $0.35 \times V_{DDQ}$ | V                  |
|                                            |                    | OE, OS                                |                       |            | $0.35 \times V_{DDQ}$ | V                  |
| High level input voltage                   | $V_{IH}$           | CLK_INT, CLK_INC, FB_INC, FB_INT      | $0.65 \times V_{DDQ}$ |            |                       | V                  |
|                                            |                    | OE, OS                                | $0.65 \times V_{DDQ}$ |            |                       | V                  |
| DC input signal voltage (note 2)           | $V_{IN}$           |                                       | -0.3                  |            | $V_{DDQ} + 0.3$       | V                  |
| Differential input signal voltage (note 3) | $V_{ID}$           | DC - CLK_INT, CLK_INC, FB_INC, FB_INT | 0.3                   |            | $V_{DDQ} + 0.4$       | V                  |
|                                            |                    | AC - CLK_INT, CLK_INC, FB_INC, FB_INT | 0.6                   |            | $V_{DDQ} + 0.4$       | V                  |
| Output differential cross-voltage (note 4) | $V_{OX}$           |                                       | $V_{DDQ}/2 - 0.10$    |            | $V_{DDQ}/2 + 0.10$    | V                  |
| Input differential cross-voltage (note 4)  | $V_{IX}$           |                                       | $V_{DDQ}/2 - 0.15$    | $V_{DD}/2$ | $V_{DDQ}/2 + 0.15$    | V                  |
| High level output current                  | $I_{OH}$           |                                       |                       |            | -9                    | mA                 |
| Low level output current                   | $I_{OL}$           |                                       |                       |            | 9                     | mA                 |
| Operating free-air temperature             | $T_A$              |                                       | 0                     |            | 70                    | $^{\circ}\text{C}$ |

**Notes:**

1. Unused inputs must be held high or low to prevent them from floating.
2. DC input signal voltage specifies the allowable DC execution of differential input.
3. Differential inputs signal voltages specifies the differential voltage [VTR-VCP] required for switching, where VTR is the true input level and VCP is the complementary input level.
4. Differential cross-point voltage is expected to track variations of  $V_{DDQ}$  and is the voltage at which the differential signal must be crossing.



## Timing Requirements

$T_A = 0 - 70^\circ\text{C}$  Supply Voltage AVDD, VDDQ = 1.8 V +/- 0.1V (unless otherwise stated)

| PARAMETER                   | SYMBOL                     | CONDITIONS             | MIN | MAX | UNITS         |
|-----------------------------|----------------------------|------------------------|-----|-----|---------------|
| Max clock frequency         | $\text{freq}_{\text{op}}$  | 1.8V $\pm$ 0.1V @ 25°C | 95  | 410 | MHz           |
| Application Frequency Range | $\text{freq}_{\text{App}}$ | 1.8V $\pm$ 0.1V @ 25°C | 160 | 410 | MHz           |
| Input clock duty cycle      | $d_{\text{tin}}$           |                        | 40  | 60  | %             |
| CLK stabilization           | $T_{\text{STAB}}$          |                        |     | 15  | $\mu\text{s}$ |

NOTE: The PLL must be able to handle spread spectrum induced skew.

NOTE: Operating clock frequency indicates a range over which the PLL must be able to lock, but in which it is not required to meet the other timing parameters. (Used for low speed system debug.)

NOTE: Application clock frequency indicates a range over which the PLL must meet all timing parameters.

NOTE: Stabilization time is the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal, within the value specified by the Static Phase Offset ( $t_{\text{AE}}$ ), after power-up. During normal operation, the stabilization time is also the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal when CK and CK go to a logic low state, enter the power-down mode and later return to active operation. CK and CK may be left floating after they have been driven low for one complete clock cycle.



## Switching Characteristics<sup>1</sup>

T<sub>A</sub> = 0 - 70°C Supply Voltage AVDD, VDDQ = 1.8 V +/- 0.1V (unless otherwise stated)

| PARAMETER                                                          | SYMBOL                        | CONDITION                | (MHz)      | MIN   | TYP  | MAX   | UNITS |
|--------------------------------------------------------------------|-------------------------------|--------------------------|------------|-------|------|-------|-------|
| Output enable time                                                 | t <sub>en</sub>               | OE to any output         | 160 to 410 |       | 4.73 | 8     | ns    |
| Output disable time                                                | t <sub>dis</sub>              | OE to any output         |            |       | 5.82 | 8     | ns    |
| Period jitter                                                      | t <sub>jit(per)</sub>         |                          | 160 to 270 | -40   |      | 40    | ps    |
|                                                                    |                               |                          | 271 to 410 | -30   |      | 30    | ps    |
| Half-period jitter                                                 | t <sub>jit(hper)</sub>        |                          | 160 to 270 | -60   |      | 60    | ps    |
|                                                                    |                               |                          | 271 to 410 | -50   |      | 50    | ps    |
| Input slew rate                                                    | SLr1(i)                       | Input Clock              | 160 to 410 | 1     | 2.5  | 4     | v/ns  |
|                                                                    |                               | Output Enable (OE), (OS) |            | 0.5   |      |       | v/ns  |
| Output clock slew rate                                             | SLr1(o)                       |                          |            | 1.5   | 2.5  | 3     | v/ns  |
| Cycle-to-cycle period jitter                                       | t <sub>jit(cc+)</sub>         |                          |            | 0     |      | 40    | ps    |
|                                                                    | t <sub>jit(cc-)</sub>         |                          |            | 0     |      | -40   | ps    |
| Dynamic Phase Offset                                               | t <sub>(O)dyn</sub>           |                          | 160 to 270 | -50   |      | 50    | ps    |
|                                                                    |                               |                          | 271 to 410 | -20   |      | 20    | ps    |
| Static Phase Offset                                                | t <sub>SPO</sub> <sup>2</sup> |                          | 271 to 410 | -50   | 0    | 50    | ps    |
| t <sub>jit(per)</sub> + t <sub>(O)dyn</sub> + t <sub>skew(o)</sub> | Σ <sub>(su)</sub>             |                          |            |       |      | 80    | ps    |
| t <sub>(O)dyn</sub> + t <sub>skew(o)</sub>                         | Σ <sub>f(h)</sub>             |                          |            |       |      | 60    | ps    |
| Output to Output Skew                                              | t <sub>skew</sub>             |                          | 160 to 270 |       |      | 40    | ps    |
|                                                                    |                               |                          | 271 to 410 |       |      | 30    | ps    |
| SSC modulation frequency                                           |                               |                          |            | 30.00 |      | 33    | kHz   |
| SSC clock input frequency deviation                                |                               |                          |            | 0.00  |      | -0.50 | %     |
| PLL Loop bandwidth (-3 dB from unity gain)                         |                               |                          |            | 2.0   |      |       | MHz   |

### Notes:

1. Switching characteristics guaranteed for application frequency range.
2. Static phase offset shifted by design.



## Parameter Measurement Information

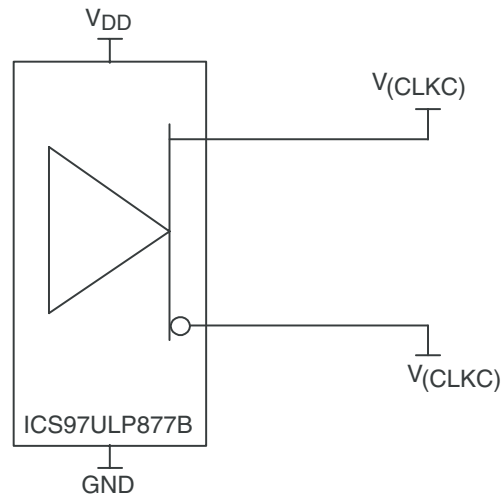


Figure 1. IBIS Model Output Load

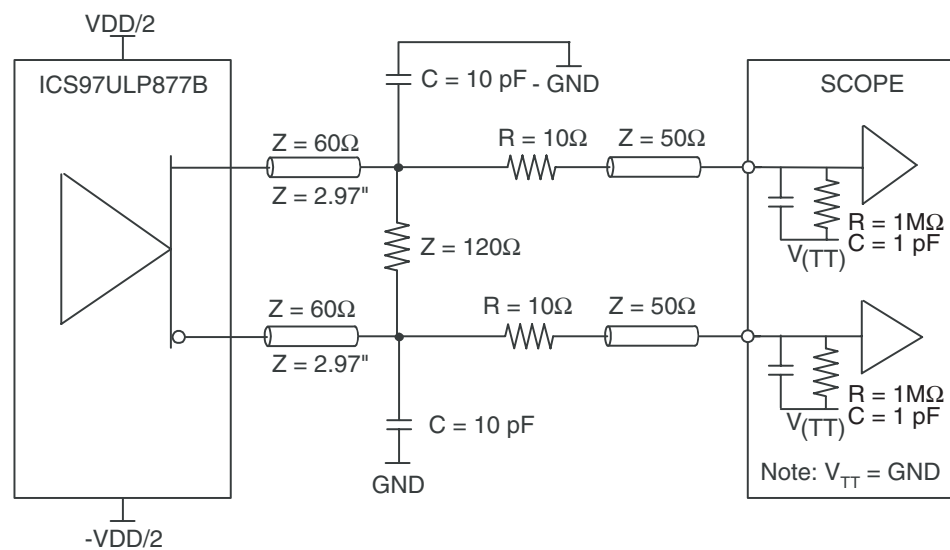


Figure 2. Output Load Test Circuit

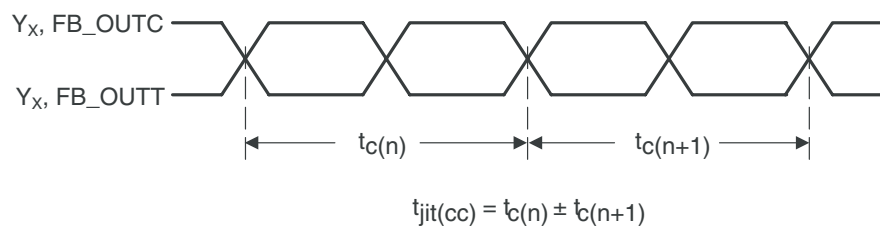
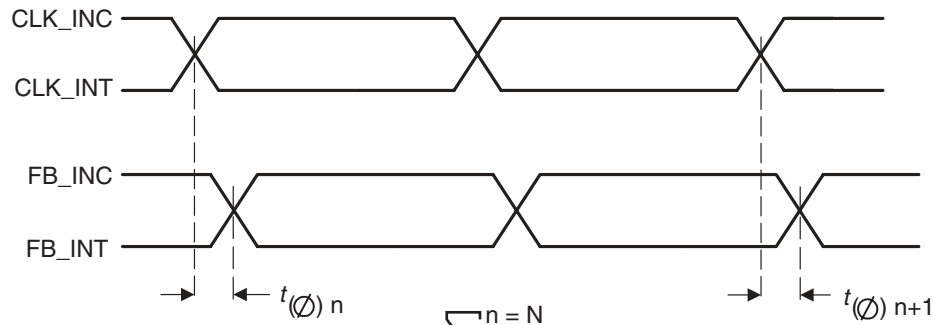


Figure 3. Cycle-to-Cycle Jitter



Parameter Measurement Information



$$t(\phi) = \frac{\sum_{n=1}^N t(\phi)_n}{N}$$

(N is a large number of samples)

Figure 4. Static Phase Offset

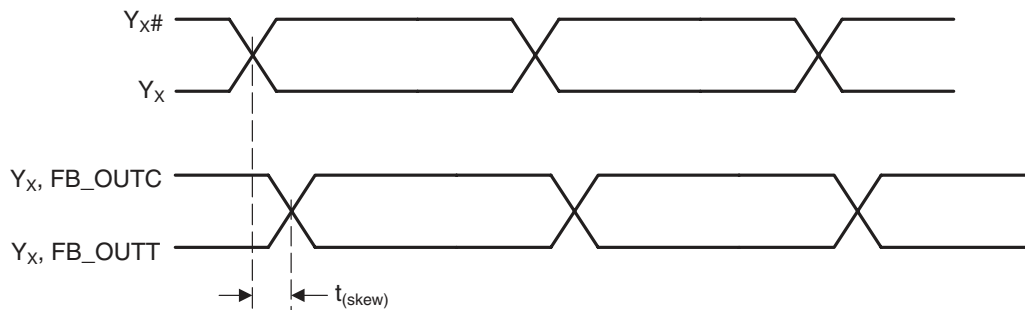
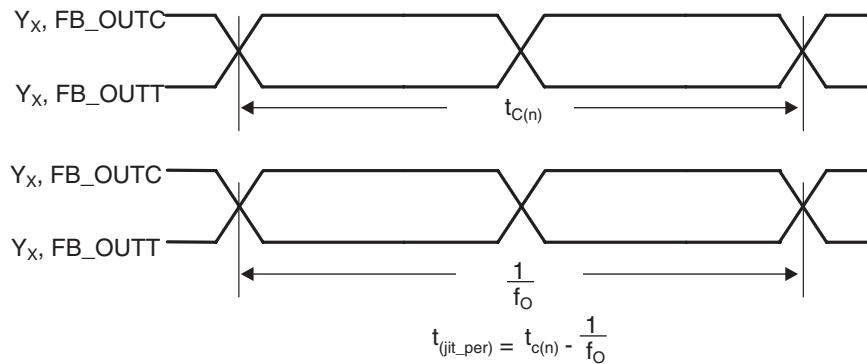


Figure 5. Output Skew



$$t_{(jit\_per)} = t_{c(n)} - \frac{1}{f_o}$$

Figure 6. Period Jitter

## Parameter Measurement Information

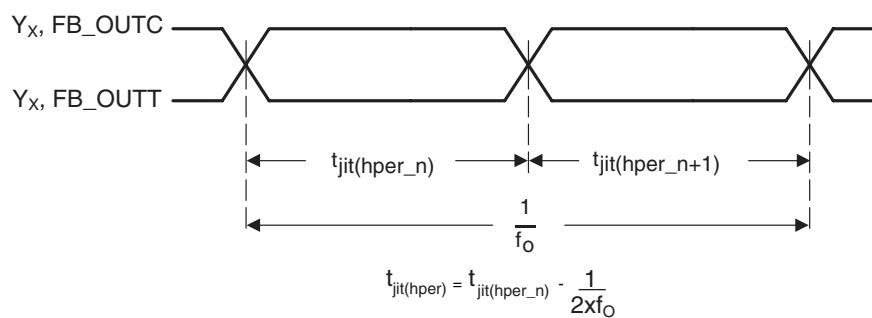


Figure 7. Half-Period Jitter

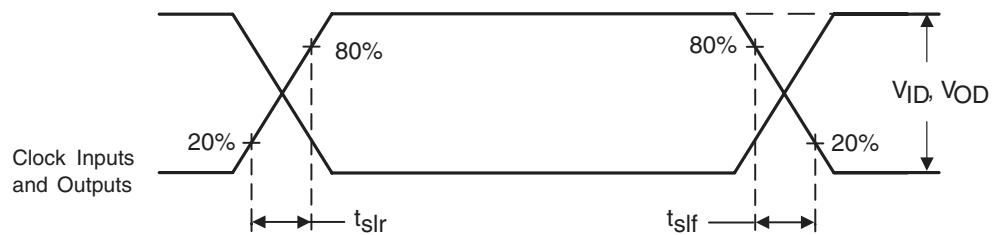


Figure 8. Input and Output Slew Rates

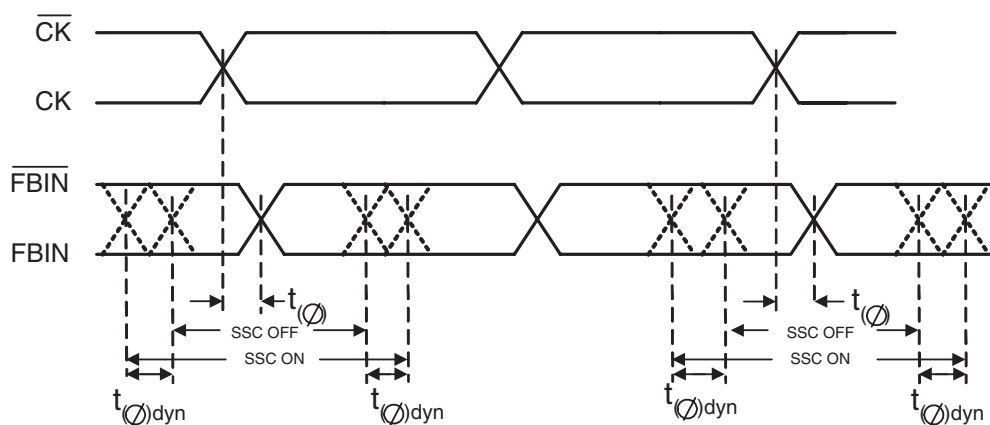


Figure 9. Dynamic Phase Offset

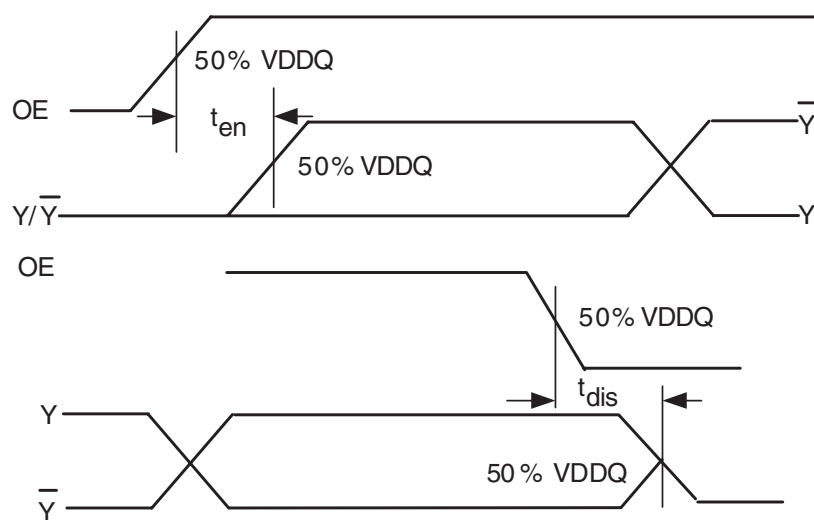
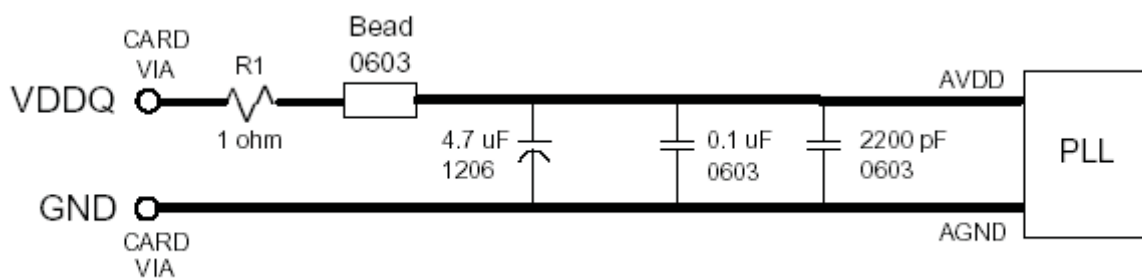
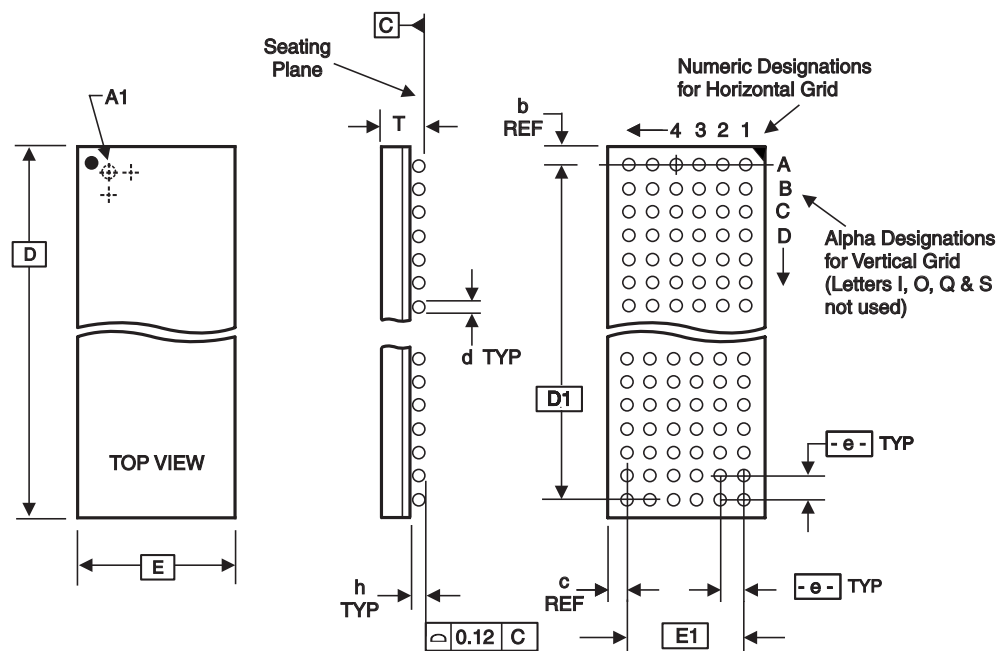


Figure 10. Time delay between OE and Clock Output ( $Y, \overline{Y}$ )

Figure 11. AV<sub>DD</sub> Filtering

- Place the 2200pF capacitor close to the PLL.
- Use a wide trace for the PLL analog power & ground. Connect PLL & caps to AGND trace & connect trace to one GND via (farthest from PLL).
- Recommended bead: Fair-Rite P/N 2506036017Y0 or equivalent (0.8 Ohm DC max, 600 Ohms @ 100 MHz).



ALL DIMENSIONS IN MILLIMETERS

| D        | E        | T<br>Min/Max | e        | --- BALL GRID --- |      | Max.<br>TOTAL | d<br>Min/Max | h<br>Min/Max | D1       | E1       | REF. DIMENSIONS |       |
|----------|----------|--------------|----------|-------------------|------|---------------|--------------|--------------|----------|----------|-----------------|-------|
|          |          |              |          | HORIZ             | VERT |               |              |              |          |          | b               | c     |
| 7.00 Bsc | 4.50 Bsc | 0.86/1.00    | 0.65 Bsc | 6                 | 10   | 60            | 0.35/0.45    | 0.15/0.21    | 5.85 Bsc | 3.25 Bsc | 0.575           | 0.625 |

Note: Ball grid total indicates maximum ball count for package. Lesser quantity may be used.

\* Source Ref.: JEDEC Publication 95, MO-205\*, MO-225\*\*

10-0055

## Ordering Information

### ICS97ULP877BHLLF-T

Example:

**ICS XXXX y H LF- T**

Designation for tape and reel packaging

Annealed Lead Free (Optional)

Package Type

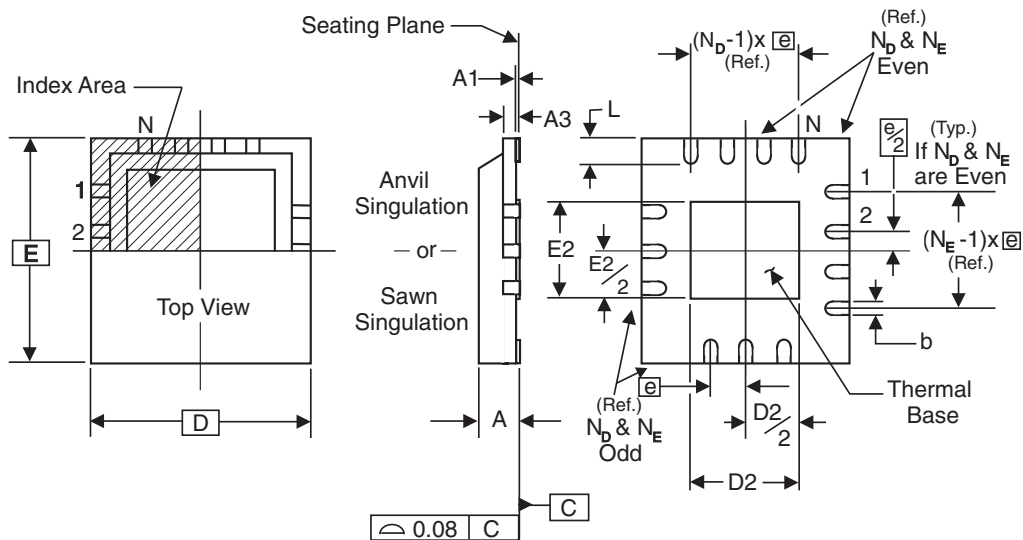
H = BGA

Revision Designator (will not correlate with datasheet revision)

Device Type

Prefix

ICS = Standard Device



## THERMALLY ENHANCED, VERY THIN, FINE PITCH QUAD FLAT / NO LEAD PLASTIC PACKAGE

ALL DIMENSIONS IN MILLIMETERS

| N              | 40          | SYMBOL | MIN.           | MAX. |
|----------------|-------------|--------|----------------|------|
| $N_D$          | 10          | A      | 0.80           | 1.00 |
| $N_E$          | 10          | A1     | 0              | 0.05 |
| D x E BASIC    | 6.00 x 6.00 | A3     | 0.25 Reference |      |
| D2 MIN. / MAX. | 2.75 / 3.05 | b      | 0.18           | 0.30 |
| E2 MIN. / MAX. | 2.75 / 3.05 | e      | 0.50 BASIC     |      |
| L MIN. / MAX.  | 0.30 / 0.50 |        |                |      |

Source Reference: MLF2™S1  
10-0053

## Ordering Information

### ICS97ULP877BKLF-T

Example:

ICS XXXX y K LF-T

Designation for tape and reel packaging

Annealed Lead Free (Optional)

Package Type

K = MLF

Revision Designator (will not correlate with datasheet revision)

Device Type

Prefix

ICS = Standard Device